



Article Effects of Annealing on Characteristics of Cu₂ZnSnSe₄/CH₃NH₃PbI₃/ZnS/IZO Nanostructures for Enhanced Photovoltaic Solar Cells

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Abstract: This paper presents new photovoltaic solar cells with Cu₂ZnSnSe₄/CH₃NH₃PbI₃(MAPbI₃)/ ZnS/IZO/Ag nanostructures on bi-layer Mo/FTO (fluorine-doped tin oxide) glasssubstrates. The hole-transporting layer, active absorber layer, electron-transporting layer, transparent-conductive oxide layer, and top electrode-metal contact layer, were made of Cu₂ZnSnSe₄, MAPbI₃ perovskite, zincsulfide, indium-doped zinc oxide, and silver, respectively. The active absorber MAPbI₃ perovskite film was deposited on Cu₂ZnSnSe₄ hole-transporting layer that has been annealed at different temperatures. TheseCu₂ZnSnSe₄ filmsexhibited the morphology with increased crystal grain sizes and reduced pinholes, following the increased annealing temperature. When the perovskitefilm thickness was designed at 700 nm, the Cu₂ZnSnSe₄ hole-transporting layer was 160 nm, and the IZO (indium-zinc oxide) at 100 nm, and annealed at 650 °C, the experimental results showed significant improvements in the solar cell characteristics. The open-circuit voltage was increased to 1.1 V, the short-circuit current was improved to 20.8 mA/cm², and the device fill factor was elevated to 76.3%. In addition, the device power-conversion efficiency has been improved to 17.4%. The output power P_{max} was as good as 1.74 mW and the device series-resistance was 17.1 Ω .

Keywords: CZTSe; hole-transporting material; perovskite; IZO; magnetron sputtering

1. Introduction

Photovoltaic (PV) devices provide electrical energy directly from sunlight, and have been one of the promising technologies in the renewable energy industry. The further improvement in the efficiency and reliability and also reduction in cost are in great demand, for the healthy development of global economy. The organic metal halide materials introduced a new generation ofthin-filmPVs, due to the excellent characteristics for light harvesting in solar cells. The optical-to-electrical power-conversion efficiency (PCE) of the lead halide perovskite- (CH₃NH₃PbI₃, or MAPbI₃) based PV device has been increased substantially in recent years [1–5]. The MAPbI₃ substance favors efficient carrier generation and transport to electrodes. It can absorb sunlight radiation from ultra-violet to infrared region. The electron-hole diffusion length could exceed 1 µm in a tri-halide perovskite absorber [6]. Kim et al. developed the first solid-state lead halide perovskite PV with fluorinated tin oxide (FTO)/TiO₂/MAPbI₃/2,2',7,7'-tetrakis(*N*,*N*-di-*p*-methoxyphenylamino)-,9,9' spiro-bifluorene (SpiroOMeTAD)/Au nanostructures [7]. Later, Jeng et al. reported the first inverted planar structure

of a lead halide perovskite solar cell [8]. Choi et al. studied conjugated polyelectrolytes as the hole-transporting materials (HTM) for inverted-type perovskite solar cells [9]. However, the organic HTM could corrode the electrode materials, which would, in turn, reduce the cell stability. Thus, inorganic type materials, such as CdTe, CuZnSnS, CuZnSnSe, CuZnSnSSe, CuInGaS, CuInGaSe, and CuInGaSSe have become interesting topics for the perovskite solar cells [10–13]. In addition, FTO should be used in favor overindium-tin-oxide (ITO) as the transparent conducting oxide(TCO), when high-temperature annealing in air is in need for PV device fabrication. This is because the ITO electrical properties can be degraded in the presence of oxygen at relatively high temperature. FTO is more stable after such a high-temperature annealing process. This good transparent conductive layer could significantly decrease photon absorption at the back electrode.

Li et al. reviewed the architectures and deposition methods in standard formation of perovskite and charge-transport layers, and provided an overview on PV device stability [14]. Christians et al. developed tailored interfaces to increase the operational stability of un-encapsulated perovskite solar cells [15]. The long-term stability performance has to be improved for different ingredients to warrant inter-carrier scalability, capability, and system durability. The actual PV devices involved frames, glasses, and other compound materials, which could further challenge the recycling scheme [16]. In addition, metal-selenide had been studied as a carrier-transporting material in perovskite by various sputtering techniques [17–19]. This paper has focused on applyingCu₂ZnSnSe₄as HTM nano-film, and fabricated by innovative concept to improve Cu-based PV performance. The HTM film should help to maintain perovskite's open-circuit voltage (Voc), short-circuit current density (J_{SC}), fill factor (FF), and stability. An ultra-thin CuZnSnSe HTM (<200 nm) between Mo metal-electrode layer and MAPbI₃ active absorber layer, would promote carrier transporting, and provide favorable ohmic-contact. The deposition of a good ohmic-contact can reduce interface carrier recombination.

Thin CuInGeSe or CuZnSnS layer could fail to maintain the high efficiency performance. The main reason behind the poor performance was the substantial drop in short-circuit current density [20–22]. The Kesterite photovoltaics that applied for Cu₂ZnSnS₄, Cu₂ZnSnSe₄, and Cu₂ZnSn(S_{1-x}Se_x)₄ emerged as one of the most assured replacements for the chalcopyrite solar cells. The constituent elements are relatively abundant on the earth. They have also demonstrated high absorption coefficients, and direct tunable energy band gaps that would allow effective absorption of photons [23]. The Cu₂ZnSnSe₄ HTM film can be deposited in 40~160 nm thickness by magnetron sputtering to achieve well carrier transport. The inorganic CuZnSnSe HTM provides low-cost procedure and material for the applications of perovskite solar cells.

Chalapathy et al. revealed high-quality CZTS films by high-temperature sulfurization of sputtered Cu/ZnSn/Cu precursor layers [24]. A highly imperfect Cu₂ZnSnSe₄ HTM/TCO material interface could be an exhaustion region, leading to high back-electrode contact layer of surface recombination. The selenium diffuses into Mo film's interface, resulting in possible selenization. The MoSe₂ film at the interface indicated structural quality for adherence and good electrical contact [25]. The outward diffusion of selenium into Mo strongly depends on the annealing temperature [26]. The reconstructed interfacial layer significantly diminishes series-resistance and enlarges shunt-resistance of the solar cell.

Aqil et al. studied the electrical and morphological appearance of the functional portion of Mo film deposition [27]. A single layer of Mo film with low resistivity and good adhesion has been deposited successfully by the radio-frequency (RF) magnetron sputtering system using appropriate parameters. The nanocrystals could be tuned by the nucleation and growth conditions [28]. The bi-layer Mo films were thus proposed to consist of a porous bottom layer and a dense top layer [29]. It has been possible to control the interfacial MoSe₂ film thickness during annealing procedure to achieve high solar cell power conversion efficiency [30,31]. The interface of CIGSe/Mo or CZTSe/Mo could improve the structural quality of planar solar cells, and affects the adherence to metal-contacts, providing excellent ohmic-contact at CIGSe/Mo or CZTSe/Mo inter-films. The development of MoSe₂ could not be formed below 500 °C. The selenization increased strongly on higher annealing temperature, also leading to nano-crystallization orientation. Nevertheless, theCIGSe/Mo or CZTSe/Mo heterojunction could

be associated with MoSe₂ film. It was not an interrelated Schottky-type but was an interconnected ohmic-contact [32,33].

Furthermore, ZnS is an ideal inorganic compound to be used as an electron-transporting layer (ETL)for the perovskite PVs [34]. When ZnS dense film is synthesized, it can be transparent, and can be used as a window for visible optics and infrared optics. The film's nanostructure relies on the deposition procedure or doping element at the growth sequence. In comparison with other complex techniques, this study employed RF (radio frequency) magnetron sputtering process for stable depositing results [35]. The MAPbI₃/ZnS interface property has been demonstrated by using ultra-violet photoelectron spectra [36]. The ZnS interfacial nano-film could promote the Voc and perovskite PCE performance on PVs. The cascade conduction band architecture effectively decreased the interfacial charge recombination and improved the electron transfer. In addition, Yuan et al. illustrated the reduction in surface defects, which improved charge extraction, extended light response, and expanded ZnS/MAPbI₃ spectral absorption [37].

Indium-doped zinc oxide (IZO) film only needs a low annealing temperature and can promote the optoelectronic characteristics. It is an amorphous transparent conducting oxide material, and has a downgraded absorption near IR (infra red) region photons, yielding to an enhanced transmission at the bottom layer on solar cells. The IZO material is a potential replacement of traditional TCO that was used as an n-type buffer layer or window transparent conductive oxide layer for photovoltaics. Nevertheless, the fabrication using all sputtering-process methodology, along with the ultra-thin Cu₂ZnSnSe₄ HTM, may develop a novel copper-based inorganic HTM for perovskite nanostructured PVs. The results should help to pave the way for the next generation thin-film solar cells and to better protect the global environment.

2. Materials and Methods

In this study, bi-layer Mo film was sputtered on FTO glass substrate as a back metal electrode contact layer. The Mo film was prepared by RF magnetron sputtering system using commercial Mo target (Ultimate Materials Technology Co., Miaoli, Taiwan). In this fabrication process, the bottom layer was deposited at a higher Ar flow working pressure, using high-power parameters, and the Ar flow rate and RF power were maintained at 70 sccm and 110 W. On the other hand, the top layer was deposited at a lower Ar flow working pressure, using lower-power parameters, and the Ar flow rate and RF power were maintained at 35 sccm and 55 W for preserving better adhesion. The bi-layer Mo films exhibited both low resistivity and good adhesion. It has been measured that the Mo bi-layer had a film resistivity of $4.37 \times 10^{-4} \Omega$ -cm, which was much lower than that of single-layer at $2.2 \times 10^{-2} \Omega$ -cm. Each layer had a thickness of ~100 nm. The Mo film also acted as a reflective layer on these multi-layered solar cells. This Mo film that was deposited under high argon pressure would be under tensile stress and adhere successfully with the substrate, but with low conductivity. The deposition by low argon pressure would render compressive stress that had low resistivity but adhered poorly to interface on the substrate.

Moreover, $Cu_2ZnSnSe_4$ film was deposited by RF magnetron sputtering using a $Cu_2ZnSnSe_4$ target (Ultimate Materials Technology Co., Miaoli, Taiwan) on bi-layer Mo. The argon flow rate and RF power were maintained at 40 sccm and 70 W, respectively. It was adopted as the HTM layer. It should promote the carrier transporting and result in a beneficial device by providing a conductive ohmic-contact. The ultra-thin $Cu_2ZnSnSe_4$ HTM (<200 nm) surface roughness corresponded to the optical absorber thickness transition, and could affect interface recombination of electrons and electron-holes. The root-mean-square surface roughness was low at ~20 nm, measured by atomic force microscopy. The $Cu_2ZnSnSe_4$ film thickness has been prepared at 40–160 nm approximately. It was then further thermally treated by the annealing temperature at 350, 450, 550, or 650 °C in a tube furnace for about 60 min in order to get magnificent crystallization.

The MAPbI₃ film was deposited on grown Cu₂ZnSnSe₄ HTM layer and by one-step spin-coating process for the inverted structures of perovskite solar cells. The photovoltaic characteristics would

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be investigated to reveal the relationships between the properties and structures. The single-step deposition involved the dissolution of PbI_2 and MAI (CH_3NH_3I) in a co-solvent, consisted of equal volumes of dimethyl sulfoxide and gamma-butyrolactone. This perovskite precursor solution was spin-coated using parameters of 1000 and 5000 rpm for 10 and 18 s, respectively, in a nitrogen-filled glove box. The wet film was then quenched by dropping 50 µL of anhydrous toluene at 15 s. Afterwards, the perovskite film was further annealed at 100 °C for 10 min. The MAPbI₃ thin-film had a thickness of 700 nm approximately.

Zinc sulfide film is an *n*-type semiconductor material and was adopted as an ETL in this multi-layered nanostructure PVs. It was prepared using a commercial target (Ultimate Materials Technology Co., Miaoli, Taiwan) by RF sputtering system. The Ar flow rate and RF power were controlled at 30 sccm and 50 W, respectively. The ZnS film was about 50 nm in thickness. The film was attributed to not only thinner ETL layer deposition, but also to extract electrons from the MAPbI₃ active absorber layer. It also required quenching at 100 °C in a tube furnace for about 10 min to achieve the ideal *p*-*n* junction, crystallization, and better ohmic-contact. The ZnS film could improve the multi-layer structures by alloying, plastic distortion and thermal annealing. It would bond with upper IZO transparent conductive oxide film, while conducting the necessary optical-current passing through, thus enhancing optical-to-electrical conversion performance.

Indium-doped zinc oxide is an n-type semiconductor material and was adopted as a transparent conductive oxide film, deposited by RF magnetron sputtering using a commercially available IZO target (Ultimate Materials Technology Co., Miaoli, Taiwan). The deposition parameters were argon flow rate at 30 sccm and RF power at 50 W. The IZO film had a thickness of 100 nm approximately. The low-temperature and high-mobility amorphous nature rendered excellent characteristics for the ZnS (ETL)/MAPbI₃/CZTSe (HTM) heterojunction solar cells.

At last, the top Ag metal electrode film was deposited over the IZO *n*-type semiconductor TCO. The Ag metal ingot was prepared on a tungsten metal-boat in the vacuum chamber of an evaporation system. The tungsten boat was connected to an external power supply and provided with a maximum current of 90 A. The Ag metal film had a thickness of ~100 nm. A shadow mask has been adopted to define an active area of 0.5×0.2 cm² during the Ag deposition. The nanostructured PV was investigated by X-ray diffraction (XRD) using PANalytical X'Pert Pro DY2840 system (Malvern Panalytical, Almelo, Netherlands) with Cu K α (λ = 0.1541 nm) radiation. The crystalline surface morphology was studied by scanning electron microscopy (Zeiss Gemini SEM, Jena, Germany). A micro-Raman spectroscopy analysis was employed using Jon-YvonLabRAM system (Horiba-HR800, Kyoto, Japan). The photoluminescence (PL) results were scanned by a fluorescence spectrophotometer (Hitachi, F-7000, Tokyo, Japan). The electron spectroscopy chemical analysis (ESCA) spectra were examined using PHI-5000 system (ULVAC, Versaprobe-II, Kanagawa, Japan). The solar cell PV characteristics were studied by a Keithley 2420 programmable source instrument under 1000 W xenon illumination with a forward scan rate of 0.1 V/s.

3. Results and Discussion

Figure 1 shows the complete scheme of the nanostructured MAPbI₃ perovskite solar cell device with the Cu₂ZnSnSe₄ HTM layer. The corresponding energy levels of the planar architecture device of Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO are illustrated in Figure 2. The ultra-thin Cu₂ZnSnSe₄ HTM has been deposited between the bi-layer Mo metal-electrode and the MAPbI₃ active absorber layer to improve carrier transporting. The energy level diagram indicated that it is a heterojunction planar photovoltaic solar cell.



Figure 1. The complete scheme of nanostructured MAPbI₃ perovskite solar cell with Cu₂ZnSnSe₄ HTM layer.



Figure 2. The corresponding energy levels of the planar architecture device of Ag/IZO/ZnS/MAPbI₃/ Cu₂ZnSnSe₄/Mo/FTO.

Figure 3 shows the XRD diffraction pattern results of the MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructures on glass substrate after the various annealing temperatures [3,21,31]. The MAPbI₃ film's nano-crystal was illustrated by one main crystal plane (110) corresponding to the 20 diffraction peak at ~14.3°. The 20 full-width at half-maximum (FWHM) was reduced from 0.39° to 0.28° when the annealing temperature was increased from 350 °C to 650 °C. Other MAPbI₃ crystal planes involved (220) at ~29.2° and (310) at ~32.4°. When the annealing temperature of the $Cu_2ZnSnSe_4$ HTM film under the MAPbI₃ film was increased, the FWHM of the Cu₂ZnSnSe₄ HTM film's nano-crystal was also improved. Its nano-crystal was illustrated by the main crystal plane (112) corresponding to the 2θ diffraction peak at ~27.1°. Its FWHM was reduced from 0.64° to 0.51° when the annealing temperature was increased from 350 to 650 °C. Other $Cu_2ZnSnSe_4$ crystal planes could be illustrated by (204) at 20 diffraction peak of ~45.1°, (312) at ~53.8°, and (008) at 65.8°. The Mo film's nano-crystal was illustrated by the main crystal plane (110) at the 2 θ diffraction peak at ~40.5°. Its FWHM was reduced from 0.98° to 0.83° when the annealing temperature was increased from 350 to 650 °C. Other Mo film's crystal planes included (200) at ~58.6°, and (211) at ~73.5°. The smaller FWHM demonstrated $MoSe_2$ nano-crystal and it could be illustrated by the main crystal plane (002) at the 20 diffraction peak at ~13.5°. The FWHM was reduced from 0.13° to 0.10° when the annealing temperature was increased from 350 to 650 °C. Other MoSe₂ crystal planes included (004) at ~28.2°, (006) at ~42.7°, and (008) at ~57.5°. The Cu₂ZnSnSe₄ HTM film has been annealed at 350, 450, 550, and 650 °C, respectively. As a result, the film's crystal quality was improved following the increased annealing temperature. Interestingly, the crystallization of MAPbI₃ active absorber layer was also preceded by the same annealing temperature. It has been noted that when one side of a heterojunction is much more heavily doped than the other side, the junction is nearly a one-sided heterojunction. To form a good quality heterojunction, the difference between the neighboring semiconductors' lattice constants should be small in order to minimize the density of interface states. The difference in electron hole affinity between two different materials should be small to minimize band discontinuity, and thermal expansion coefficients should be close as well. MAPbI₃ film and $Cu_2ZnSnSe_4$ HTM film were likely annealed and sintered altogether.



Figure 3. XRD diffraction pattern results of the MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructures on glass substrate after the various annealing temperatures.

Furthermore, their energy band gaps were similar for trapping light simultaneously. It would be beneficial to constitute pairs of excited electrons and associated electron holes. Eventually, the carriers could increase the optical-electronic power-conversion efficiency and optical-current associated in the photovoltaic cell's multi-layer nanostructures.

Figure 4 shows the top-view SEM micrographs of the surface morphology of Cu₂ZnSnSe₄ HTM layers after the various annealing temperatures. The magnetron sputtered film provided full surface coverage and was composed of small crystal grains ranging from tens of nm to one μ m in size. After its deposition, the bi-layer Mo film became indiscernible. However, the Cu₂ZnSnSe₄ nano-crystal grainsize was significantly enlarged with the increased annealing temperature. For the 350 °C-annealed sample, it exhibited relatively small crystal grains from tens to two hundred nm. It contained some pinhole-type of defects. Figure 4b showed Cu₂ZnSnSe₄ film surface appearance with tens to four hundred nm in grain sizefor 450 °C. Figure 4c showed film surface with tens to six hundred nm in the grain sizefor 550 °C. It also contained less pinholes at the same magnification. Figure 4d showed the Cu₂ZnSnSe₄ film surface morphology for 650 °C. It demonstrated better crystallization, with crystal grains as large as one μ m in size. Much less pinholes could be found. Thus, the higher annealing temperature achieved high-quality surface HTM films. Additionally, the Cu₂ZnSnSe₄ HTM film's hole mobility was increased from 15.1 cm²/(V s) to 29 cm²/(V s), while the annealing temperature was increased from 350 to 650 °C. The higher carrier mobility would help to reduce the device series-resistance, and improve performance for the nanostructured photovoltaic cells.



Figure 4. Top-view SEM micrographs of theCu₂ZnSnSe₄ HTM layers after the various annealing temperatures of: (a) $350 \degree$ C; (b) $450 \degree$ C; (c) $550 \degree$ C; (d) $650 \degree$ C.

Figure 5 shows the compositional dependence of Raman spectra of the $Cu_2ZnSnSe_4$ HTM nano-films after the various annealing temperature treatments. In this fabrication, $Cu_2ZnSnSe_4$ HTM film exhibited dominant spectra with intense Raman scattering main peak at 194 cm⁻¹ correlating with the optical phonon mode. Its intensity increased slightly with the increased thermal annealing temperature. Other Raman scattering peak intensities were found at 233 and 253 cm⁻¹. The $Cu_2ZnSnSe_4$ HTM crystal orientation could be found from polarization of Raman-scattered light with respect to the laser light, if the crystal structure's point group could be known.



Figure 5. The compositional dependence of Raman spectra of the $Cu_2ZnSnSe_4$ HTM nano-films. The arrows point towards the corresponding wave numbers.

Figure 6 shows the measurement results of the absorbance spectra of $Cu_2ZnSnSe_4$ HTM nano-films after the various annealing temperatures. The optical absorption properties of $Cu_2ZnSnSe_4$ in the

visible region and near-infrared region are associated with electronic transitions and are also useful in comprehending electronic band conformations of semiconducting films. The optical spectra were recorded using a UV (ultraviolet) spectrophotometer at the wavelength range from 300 to 1200 nm. It was observed that the absorbance intensity increased with the increased annealing temperature. This was presumably caused by free-carrier absorption corresponding to conductivity. These absorption spectra illustrated that all Cu₂ZnSnSe₄ nano-films absorb over the entire visible region of electromagnetic waves. The absorption spectra data were analyzed following a classical equation for near edge optical absorption of semiconductors: $\alpha h\nu = A(h\nu - E_g)^n$, where α is absorption coefficient, hv is photon energy, E_g is energy band gap, A is constant, n can have values of 1/2, 2, 3/2 and 3 for allowed direct, allowed indirect, forbidden direct and forbidden indirect transitions, separately. The Cu₂ZnSnSe₄ energy band gap was determined by plotting a graph of hv versus (αhv)², for the direct band gap. The energy band gap was designated by extrapolating the straight line portion to the energy axis, whose intercept to the x-axis should give the optical energy band gap [38]. An example graph for Cu₂ZnSnSe₄annealed at 650 °C is provided in Figure 7, and the calculation result of energy band gap has been 1.07–1.1 eV for the ultra-thin Cu₂ZnSnSe₄ HTM which was deposited on bi-layer Mo/FTO glass substrate. It should promote a valence electron bound to an atom to a conduction electron. Such electrons then move freely within the HTM and become carriers that can conduct current.



Figure 6. The absorbance spectra of $Cu_2ZnSnSe_4$ HTM nano-films after the various annealing temperatures.



Figure 7. Graph of hv versus $(\alpha hv)^2$ for measuring the optical energy bandgap of Cu₂ZnSnSe₄. It was determined by extrapolating the straight line portion to the photon energy axis.

Figure 8 displays the graphic current-density voltage (*J*–*V*) curves of Ag/IZO/ZnS/Cu₂ZnSnSe₄/ Mo/FTO nanostructured solar cells. The Cu₂ZnSnSe₄ HTM layer thickness has been varied at 40~160 nm, and the thermal annealing temperature was all at 650 °C. Additionally, Table 1 summarizes the PV characteristic parameters of these nanostructured solar cells, without MAPbI₃ perovskite, under 100 mW/cm² illumination (air mass, AM1.5G). It has been evidenced that the open-circuit voltage increased from 0.36 to 0.39 V, following the increased HTM layer thickness from 40 to 160 nm. The device short-circuit current was also enlarged from 6.47 to 9.46 mA/cm². The device fill factor value would be amplified from 39.5% to 46.3%. The PV device power-conversion efficiency value was slightly increased from 0.92% to 1.71%, and the output power P_{max} value was enhanced from 0.09 to 0.17 mW. Additionally, the Cu₂ZnSnSe₄ film alone could not absorb enough photons, so that the PV cells exhibited poor PCE performance in the illustration.



Figure 8. The *J*–*V* curves of Ag/IZO/ZnS/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells, under 100 mW/cm² illumination. The Cu₂ZnSnSe₄ HTM layer thickness has been varied at 40–160 nm.

Table 1. The PV characteristic parameters of the Ag/IZO/ZnS/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells.

Cu ₂ ZnSnSe ₄ HTM Thickness (nm)	V_{OC} (V)	J_{SC} (mA/cm ²)	FF (%)	<i>Eff</i> (%)	P _{max} (mW)
40	0.36	6.47	39.5	0.92	0.09
80	0.37	7.47	40.9	1.13	0.11
120	0.38	8.52	45.1	1.46	0.15
160	0.39	9.46	46.3	1.71	0.17

Figure 9 displays the graphic *J*–*V* curves of Ag/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells, with the MAPbI₃ perovskite nanostructures on bi-layer Mo. The Cu₂ZnSnSe₄ HTM layer thickness has been fixed at 160 nm, but was thermally treated at the various annealing temperature 350–650 °C. The measurements were, again, under 100 mW/cm² illumination. Table 2 lists the derived PV characteristic parameters of the Ag/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells. It has been clearly evidenced with significant improvements in all the parameters. The open-circuit voltage was increased from 0.89 to 0.98 V following the increased annealing temperature from 350 to 650 °C. The short-circuit current was also expanded from 19.9 to 20.4 mA/cm². The device fill factor value could be increased from 68.6% to 71.3%. The PV device power-conversion efficiency value was strengthened from 12.2% to 14.3%, and the output power P_{max} value was enhanced from 1.22 to 1.43 mW.



Figure 9. The *J*–*V* curves of Ag/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells, under 100 mW/cm² illumination. The Cu₂ZnSnSe₄HTM has been thermally treated at the various annealing temperature 350–650 °C.

Table 2. The PV characteristic parameters of the Ag/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells.

Cu ₂ ZnSnSe ₄ HTM Annealing Temperature (°C)	V_{OC} (V)	J _{SC} (mA/cm ²)	FF (%)	<i>Eff</i> (%)	P _{max} (mW)
350	0.89	19.9	68.6	12.2	1.22
450	0.92	20.1	70.9	13.1	1.31
550	0.95	20.2	71.2	13.8	1.38
650	0.98	20.4	71.3	14.3	1.43

In addition, Figure 10 displays the *J*–*V* curves of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells at the various HTM thermal annealing temperatures under 100 mW/cm² illumination. The TCO layer in thickness of 100 nm IZO film has been inserted between the ZnS ETL and top Ag electrode. Table 3 presents the derived PV characteristic parameters of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells. Furthermore, it has been clearly evidenced with enhancements in all the parameters. The open-circuit voltage was amplified from 0.97 to 1.10 V, following the annealing temperature that was increased from 350 to 650 °C. The short-circuit current was slightly increased from 20.5 to 20.8 mA/cm². The device fill factor value was slightly diminished to 76.3%. The PV device power-conversion efficiency value was further increased from 15.5% to 17.4%. Additionally, the device series-resistance was decreased from 20.2 to 17.1 Ω ., and the device output power *P*_{max} value could be enhanced from 1.55 to 1.74 mW.

Figure 11 shows the PL spectral measurement results of MAPbI₃ perovskite nano-films $onCu_2ZnSnSe_4/Mo/FTO$ following the various thermal annealing temperatures. The spectra were examined by fluorescence spectrophotometer. It has been clearly evidenced with one main peak at the wavelength of ~768 nm. The intensity was also enhanced by the increased annealing temperature. The intensity of PL spectrum is relative to lifetime of the injected electrons and electron-holes combined to form excitons. An exciton indicates a mobile energy constitution by an excited electron and a relative electron-hole. Anincrease in the number of excitons could simultaneously increase the electron/electron-hole recombination, thus the PL intensity.



Figure 10. The *J*–*V* curves of Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells, under 100 mW/cm² illumination. The IZO layer thickness has been 100 nm.

Table 3. The PV characteristic parameters of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells.

Cu ₂ ZnSnSe ₄ HTM Annealing Temperature (°C)	V_{OC} (V)	J _{SC} (mA/cm ²)	FF (%)	<i>Eff</i> (%)	R_s (Ω)	P _{max} (mW)
350	0.97	20.5	77.6	15.5	20.2	1.55
450	1.02	20.6	76.4	16.1	19.7	1.61
550	1.06	20.7	76.3	16.8	18.2	1.68
650	1.10	20.8	76.3	17.4	17.1	1.74



Figure 11. PL spectra of MAPbI₃ perovskite nano-films on Cu₂ZnSnSe₄/Mo/FTO following the various thermal annealing temperatures.

Figure 12 displays the external quantum efficiency (EQE) spectrum measurement results based on Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells after the various annealing temperatures. The EQE curves for the planar solar cells have been well increased in the wavelength range of 300~800 nm from the 350 °C to 650 °C samples. Among the results of these measurements, the maximum EQE value reached nearly 85% at 550 nm for the 650 °C sample, as compared to 63% for the 350 °C sample. The higher EQE value could suggest a reduction of recombination centers. Planar solar cells involved translational electrical field distribution. It was determined entirely by 1-dimensional resonance.



Figure 12. The EQE spectra based on Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells.

Figure 13 shows the cross-sectional SEM micrograph of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/ Mo/FTO nanostructures on glass substrate. This sample has been annealed at 650 °C. The MAPbI₃ perovskite solar cell was evidenced with a glossy cross-section, contained few pinholes and micro-crack type of defects. The planar solar cell had uniform layer distribution through the magnetron sputtering technique and the spin-coating process. The thickness of each constituent layer could be clearly identified. Consequently, the nano-crystals were of high quality from this fabrication process, and the PV cell characteristics should be warranted in this study. In addition, Figure 14 shows the SEM micrographs of MAPbI₃ perovskite films on Cu₂ZnSnSe₄/Mo/FTO following the various thermal annealing temperatures. The crystal grains exhibited good surface coverage and were significantly increased in size with the increased annealing temperature.



Figure 13. SEM cross-sectional micrograph of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructures on glass substrate.

Figure 15 demonstrates the secondary ion mass spectrometry (SIMS) depth profile of the $Cu_2ZnSnSe_4$ HTM nano-film grown on bi-layer Mo/FTO glass substrate, using ESCA PHI-5000 system (Ulvac-PHI, Kanagawa, Japan). This sample has been annealed at 650 °C. The addition of Cu-based $Cu_2ZnSnSe_4$ material, including selenide and MoSe₂ inter-film, had beneficial effect on the

power conversion efficiency. The SIMS analysis provided quantitative depth profiling with good depth resolution. These features became essential to characterize the ultra-thin $Cu_2ZnSnSe_4$ HTM solar cells, where possible variations on structure or composition could lead to significant changes. In this study, $Cu_2ZnSnSe_4$ HTM film was prepared by magnetron sputtering with 160 nm in thickness, and bi-layer Mo back contact layer at about 200 nm on FTO glass substrate, all well evidenced in the depth profile. It has been noted that the use of a large collection area would provide a more representative sampling of the results. Nevertheless, the SIMS depth profile can be reconstructed after the deposition analysis to provide compositional changes at different locations.



Figure 14. SEM micrographs of MAPbI₃ perovskite films on Cu₂ZnSnSe₄/Mo/FTO following the various thermal annealing temperatures: (**a**) 350 °C; (**b**) 450 °C; (**c**) 550 °C; (**d**) 650 °C.



Figure 15. SIMS depth profile of the Cu₂ZnSnSe₄ HTM nano-film grown on bi-layer Mo/FTO glass.

4. Conclusions

In summary, one-step magnetron sputtered Cu₂ZnSnSe₄ nano-films have been successfully applied as novel Cu-based inorganic HTM for MAPbI₃ perovskite nanostructured photovoltaics. The adequate control in nano-film quality significantly improved the PV characteristic parameters of Ag/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells. When the Cu₂ZnSnSe₄ HTM thickness was designed at 160 nm, and the thermal annealing temperature wasat 650 °C, its open-circuit voltage was increased to 0.98 V, and short-circuit current was increased to 20.4 mA/cm². The device fill factor value was increased to 71.3%, the power-conversion efficiency value was elevated to 14.3%, and the output power P_{max} value was enhanced to 1.43 mW. Furthermore, the additional inclusion of transparent conductive IZO could further enhance the PV characteristic parameters of the Ag/IZO/ZnS/MAPbI₃/Cu₂ZnSnSe₄/Mo/FTO nanostructured solar cells. The open-circuit voltage was enhanced to 1.10 V, and the short-circuit current was increased to 20.8 mA/cm². The device fill factor value was improved to 76.3%, the power-conversion efficiency value was increased to 17.4%, the device series-resistance was decreased to 17.1 Ω., and the device output power P_{max} value could be enhanced to 1.74 mW. Therefore, the Cu₂ZnSnSe₄ HTM used in this study would help the development of perovskite PV technology.

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